

Notice of References Cited	Application/Control No. 10/602,355		Applicant(s)/Patent Under Reexamination SCHIFF, LEONARD N.	
	Examiner RICHARD CHAN		Art Unit 2618	Page 1 of 1

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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